	Application/Control No.	Applicant(s)/Patent Under Reexamination
Issue Classification	10540514	OSADA ET AL.
	Examiner	Art Unit
	Liu, Benjamin T	2826

			Examiner					Art Unit	i		
			Liu, Benjamin T					2826	:		
		ORIGINAL					2	INTERNATIONAL CLASSIFICATION	- CLASS	SIFICATION	
	CLASS		SUBCLASS				CLAIMED	ED		NON-CLAIMED	AIMED
257		194			Ξ	-	١	31 / 00			
		CROSS REFERENCE(S)	NCE(S)								
CLASS		SUBCLASS (ONE S	SUBCLASS (ONE SUBCLASS PER BLOCK)								
257	192	E31.053 E33.027	.027 E21.403	E21.407							
438	172										
						\dashv					
						-					
					\downarrow	+					
	The state of the s		The state of the s			-					
					1	-					
						_					
						-		·			
						+		-			
Benjamin Tzu-Hung Liu	-Hung Liu	7/11/07								Total Claims Allowed:	s Allowed:
(Assistant Examiner)	aminer)	(Date)	\$	Š			,			9	10
alent	Rey Jewbler	7/25/07	SUPERVISORY PATENT EXAMINER	A. PURVIS	AMINE	E.	2/2	1/23/01	0.G. P.	O.G. Print Claim(s)	O.G. Print Figure
(Legal Instrum	(Legal Instruments Examiner)	(Date)	(Primary Examiner)			(Date)	- (e)	_		-	~
											7 C

U.S. Patent and Trademark Office